

# **Quad 3-State Noninverting Buffers**

### **Features**

Output Drive Capability: 15 LSTTL Loads

Outputs Directly Interface to CMOS, NMOS, and TTL

• Operating Voltage Range: 2.0 to 6.0 V

Low Input Current: 1.0 μA

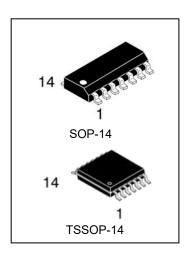
High Noise Immunity Characteristic of CMOS Devices

• In Compliance with the JEDEC Standard No. 7A Requirements

• ESD Performance: HBM > 2000 V; Machine Model > 200 V

• Chip Complexity: 72 FETs or 18 Equivalent Gates

• These are Pb-Free Devices



### **Ordering Information**

DEVICE	Package Type	MARKING	Packing	Packing Qty
74HC125M/TR	SOP-14	74HC125	REEL	2500pcs/Reel
74HC125MT/TR	TSSOP-14	HC125	REEL	2500pcs/Reel

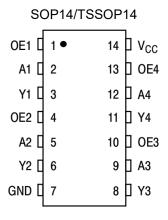


### **High-Performance Silicon-Gate CMOS**

The 74HC125 is identical in pinout to the LS125. The device inputs are compatible with standard CMOS outputs; with pullup resistors, they are compatible with LSTTL outputs.

The 74HC125 noninverting buffer is designed to be used with 3-state memory address drivers, clock drivers, and other bus-oriented systems. The device has four separate output enables that are active-low.

### **Pin Connection**



### **Function Table**

74HC125							
Inputs Output							
Α	OE	Υ					
Н	L	Н					
L	L	L					
Х	Н	Z					

### **Logic Diagram**

# 74HC125 Active-Low Output Enables A1 2 3 Y1 OE1 1 A2 5 6 Y2 OE2 4 A3 9 8 Y3 OE3 10 A4 12 11 Y4 OE4 13 PIN 14 = V<sub>CC</sub> PIN 7 = GND



### **Maximum Ratings**

Symbol	Parameter	Value	Unit
Vcc	DC Supply Voltage (Referenced to GND)	- 0.5 to + 7.0	V
V <sub>in</sub>	DC Input Voltage (Referenced to GND)	- 0.5 to V <sub>CC</sub> + 0.5	V
V <sub>out</sub>	DC Output Voltage (Referenced to GND)	- 0.5 to V <sub>CC</sub> + 0.5	V
l <sub>in</sub>	DC Input Current, per Pin	±20	mA
l <sub>out</sub>	DC Output Current, per Pin	±35	mA
Icc	DC Supply Current, VCC and GND Pins	±75	mA
P <sub>D</sub>	Power Dissipation in Still Air, SOP Package† TSSOP Package†	500 450	mW
T <sub>stg</sub>	Storage Temperature	- 65 to + 150	°C
T∟	Lead Temperature, 1 mm from Case for 10 Seconds (SOP or TSSOP Package)	245	°C

**Note**: Absolute Maximum Ratings indicate limits beyond which damage to the device may occur. Operating Ratings indicate conditions for which the device is intended to be functional, but specific performance is not ensured.

This device contains protection circuitry to guard against damagedue to high static voltages or electric fields. However, precautions must be taken to avoid applications of anyvoltage higher than maximum rated voltages to this high-impedance circuit. For proper operation,  $V_{in}$  and  $V_{out}$  should be constrained to the range  $GND \le (V_{in} \text{ or } V_{out}) \le VCC$ . Unused inputs must always be tied to an appropriate logic voltage level (e.g., either GND or VCC).

Unused outputs must be left open.Stresses exceeding Maximum Ratinommended Operating Conditions may affect device reliability.†Derating – SOP Package: – 7 mW/°C from 65° to 125°C TSSOP Package: – 6.1 mW/°C fgs may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recrom 65° to 125°C

### **Recommended Operating Conditions**

Symbol	Parameter	Min	Max	Unit	
Vcc	DC Supply Voltage (Referenced to GND)	2.0	6.0	V	
Vin, Vout	DC Input Voltage, Output Voltage (Referenced to	0	VCC	V	
T <sub>A</sub>	Operating Temperature, All Package Types	-40	+ 85	°C	
	Input Rise and Fall Time	V <sub>CC</sub> = 2.0 V	0	1000	
$t_r$ , $t_f$	'	V <sub>CC</sub> = 4.5 V	0	500	ns
	(Figure 1)	V <sub>CC</sub> = 6.0 V	0	400	



# Dc Electrical Characteristics (Voltages Referenced to GND)

				Gua	aranteed L	imit	
Symbol	Parameter	Test Conditions	V <sub>cc</sub> (V)	-40 to 25°C	≤ 85°C	≤ 125°C	Unit
			2.0	1.5	1.5	1.5	
V <sub>IH</sub>	Minimum High-Level	$V_{out} = 0.1 \text{ V or } V_{CC} - 0.1 \text{ V}$	3.0	2.1	2.1	2.1	.,
VIH	Input Voltage	I <sub>out</sub>   ≤ 20 μΑ	4.5	3.15	3.15	3.15	V
			6.0	4.2	4.2	4.2	
			2.0	0.5	0.5	0.5	
	Maximum Low-Level	$V_{out} = 0.1 \text{ V or } V_{CC} - 0.1 \text{ V}$	3.0	0.9	0.9	0.9	.,
VIL	Input Voltage	I <sub>out</sub>   ≤ 20 µA	4.5	1.35	1.35	1.35	V
		6.0	1.8	1.8	1.8		
		\ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \	2.0	1.9	1.9	1.9	
		$V_{in} = V_{IH} \text{ or } V_{IL}$		4.4	4.4	4.4	
Minimum High Lovel	National Control of the Control	I <sub>out</sub>   ≤ 20 µA	6.0	5.9	5.9	5.9	V
Vон	V <sub>OH</sub> Minimum High-Level Output Voltage	$V_{in} = V_{IH} \text{ or } V_{IL}$ $ I_{out}  \le 2.4 \text{ mA}$	3.0	2.48	2.34	2.20	
		    I <sub>out</sub>   ≤ 4.0 mA	4.5	3.98	3.84	3.70	
		I <sub>out</sub>   ≤ 5.2 mA	6.0	5.48	5.34	5.20	
		., ., .,	2.0	0.1	0.1	0.1	
		$V_{in} = V_{IH} \text{ or } V_{IL}$	4.5	0.1	0.1	0.1	
	<b>.</b>	I <sub>out</sub>   ≤ 20 μA	6.0	0.1	0.1	0.1	
V <sub>OL</sub>	Maximum Low-Level Output Voltage	$V_{in} = V_{IH} \text{ or } V_{IL}$	3.0	0.26	0.33	0.40	V
		I <sub>out</sub>   ≤ 2.4 mA	4.5	0.26	0.33	0.40	
		$ I_{out}  \le 4.0 \text{ mA}$ $ I_{out}  \le 5.2 \text{ mA}$	6.0	0.26	0.33	0.40	
l <sub>in</sub>	Maximum Input Leakage Current	V <sub>in</sub> =V <sub>CC</sub> or GND	6.0	±0.1	±1.0	±1.0	μА
loz	Maximum Three-State Leakage Current	Output in High-Impedance State $V_{in} = V_{IL}$ or $V_{IH}$ $V_{out} = VCC$ or GND	6.0	0.5	5.0	10	μΑ
Icc	Maximum Quiescent Supply Current (per Package)	V <sub>in</sub> =V <sub>CC</sub> or GND I <sub>out</sub> =0 μA	6.0	2.0	20	40	μА



# Ac Electrical Characteristics ( $C_L$ = 50 pF, Input $t_r$ = $t_f$ = 6.0 ns)

			Gua	aranteed L	imit	
Symbol	Parameter	V <sub>cc</sub> (V)	-40 to	≤ 85°C	≤ 125°C	Unit
			25°C		20 0	
		2.0	90	115	135	
t <sub>PLH</sub> ,	Maximum Propagation Delay, Input A to Output Y	3.0	36	45	60	ns
t <sub>PHL</sub>	(Figures 1 and 3)	4.5	18	23	27	113
		6.0	15	20	23	
		2.0	120	150	180	
t <sub>PLZ,</sub>	Maximum Propagation Delay, Output Enable to Y	3.0	45	60	80	ns
$t_{\text{PHZ}}$	(Figures 2 and 4)	4.5	24	30	36	115
		6.0	20	26	31	
		2.0	90	115	135	
$t_{\text{PZL}},$	Maximum Propagation Delay, Output Enable to Y	3.0	36	45	60	no
$t_{PZH}$	(Figures 2 and 4)	4.5	18	23	27	ns
		6.0	15	20	23	
		2.0	60	75	90	
t <sub>TLH</sub> ,	Maximum Output Transition Time, Any Output	3.0	22	28	34	
t <sub>THL</sub>	(Figures 1 and 3)	4.5	12	15	18	ns
		6.0	10	13	15	
Cin	Maximum Input Capacitance	-	10	10	10	pF
	Maximum 3-State Output Capacitance (Output in		45	4.5	45	
C <sub>out</sub>	High-Impedance State)	_	15	15	15	pF
CPD	Power Dissipation Capacitance (Per Buffer)*		Typical @	nF		
0, 0	i ower bissipation capacitance (i ei bullei)			pF		

<sup>\*</sup> Used to determine the no-load dynamic power consumption:  $P_D = C_{PD} V_{CC}^{2f} + I_{CC} V_{CC}$ .



# **Switching Waveforms**

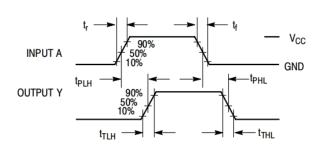


Figure 1.

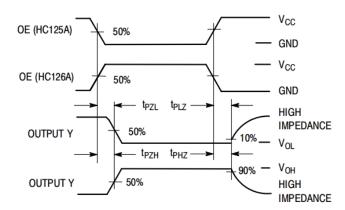
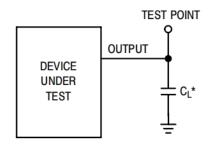
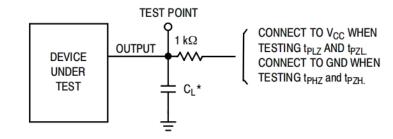


Figure 2.

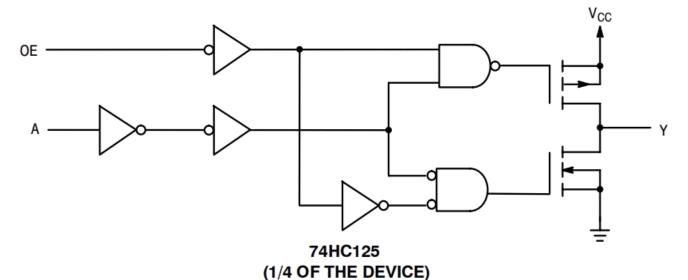




\*Includes all probe and jig capacitance

Figure 4. Test Circuit

Figure 3. Test Circuit

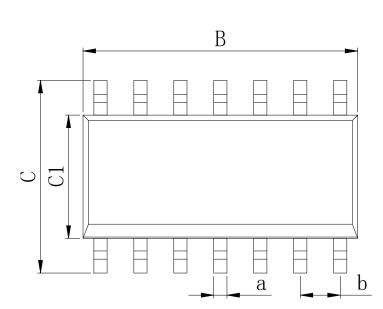


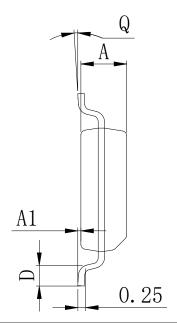
<sup>\*</sup>Includes all probe and jig capacitance



# **Physical Dimensions**

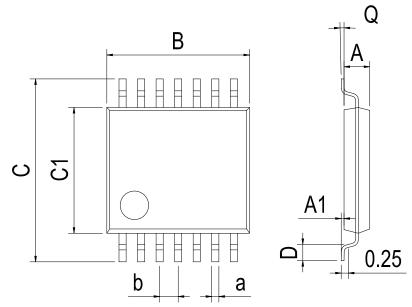
# SOP-14





Dimensions In Millimeters(SOP-14)									
Symbol:	А	A1	В	С	C1	D	Q	а	b
Min:	1.35	0.05	8.55	5.80	3.80	0.40	0°	0.35	1 27 DCC
Max:	1.55	0.20	8.75	6.20	4.00	0.80	8°	0.45	1.27 BSC

TSSOP-14



Dimensions In Millimeters(TSSOP-14)									
Symbol:	Α	A1	В	С	C1	D	Q	а	р
Min:	0.85	0.05	4.90	6.20	4.30	0.40	0°	0.20	- 0.65 BSC
Max:	0.95	0.20	5.10	6.60	4.50	0.80	8°	0.25	



# **Revision History**

DATE	REVISION	PAGE
2014-9-6	New	1-9
2023-9-18	Update Lead Temperature、Update encapsulation type、Add annotation for Maximum Ratings.	1、3



### **IMPORTANT STATEMENT:**

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NL17SZU04P5T5G 74LVC06ADTR2G 74LVC04ADR2G NLV37WZ04USG NLX3G14FMUTCG NL17SZ04P5T5G NL17SG14P5T5G
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NLX2GU04AMX1TCG 74HCT04DT 74HCT14DT 74LCX14FT(AJ) GN14D GN4069 74HC04DM/TR HG74HC04M/TR CD4007BE
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